# SOLID STATE DEVICES, INC.

14830 Valley View Blvd \* La Mirada, Ca 90638

Phone: (562) 404-7855 \* Fax: (562) 404-1773

## **DESIGNER'S DATA SHEET**

### **FEATURES:**

- Advanced high-cell density withstands high energy
- Very low conduction and switching losses
- Fast recovery drain-to-source diode with soft recovery
- **Rugged construction with poly silicon gate**
- Ultra low RDS (on) and high transconductance •
- **Excellent high temperature stability**
- Very fast switching speed
- Fast recovery and superior dv/dt performance
- Increased reverse energy capability
- Low input and transfer capacitance for easy paralleling
- Hermetically sealed package
- TX, TXV and Space Level screening available

## **SFF75N06M SFF75N06Z**

**75 AMP 60 VOLTS**  $15m\Omega$ **N-CHANNEL POWER MOSFET** 



MAXIMUM RATINGS				
CHARACTERISTIC		SYMBOL	VALUE	UNIT
Drain to Source Voltage		V <sub>DS</sub>	60	Volts
Drain to Gate Voltage (RGS = 1.0 m $\Omega$ )		V <sub>DG</sub>	60	Volts
Gate to Source Voltage		V <sub>GS</sub>	<u>+</u> 20	Volts
Continuous Drain Current		ID	56 <u>1/</u>	Amps
<b>Operating and Storage Temperature</b>		Top & Tstg	-55 to +150	°C
Thermal Resistance, Junction to Case		R <sub>OJC</sub>	1	°C/W
Total Device Dissipation	@ TC = 25°C @ TC = 55°C	PD	125 95	Watts





Available with Glass or Ceramic Seals. Contact Facory for details.

NOTE: All specifications are subject to change without notification. SCDs for these devices should be reviewed by SSDI prior to release.

**DATA SHEET #: F00311B** 



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<b>ELECTRICAL CHARACTERISTICS</b> @ $T_J = 25^{\circ}C$ (Unless Otherwise Specified)									
RATING		SYMBOL	MIN	ТҮР	MAX	UNIT			
Drain to Source Breakdown Voltage (VGS =0 V, ID = 250µA)		BV <sub>DSS</sub>	60	-	-	v			
Drain to Source on State ResistanceID=37.5A $(VGS = 10 V,Tc = 150^{\circ}C)$ ID=75AID=37.5A		R <sub>DS(on)</sub>	-	13 15 19		mΩ			
<b>On State Drain Current</b> (VDS > ID(on) x RDS(on) Max, VGS = 10 V)		I <sub>D(on)</sub>	75	-	-	Α			
Gate Threshold Voltage (VDS = VGS, ID = 250µA)		V <sub>GS(th)</sub>	2	-	4.0	V			
<b>Forward Transconductance</b> (VDS > ID(on) X RDS (on) Max, IDS=60% rated ID)		gf <sub>s</sub>	15	35	-	Smho			
Zero Gate Voltage Drain Current $(V_{DS} = 80\% \text{ rated voltage}, V_{GS} = 0V)$ $(V_{DS} = 80\% \text{ rated } V_{DS}, V_{GS} = 0V, T_A = 125^{\circ}C)$		I <sub>DSS</sub>	-	-	250 1000	μА			
Gate to Source Leakage Forward Gate to Source Leakage Reverse	At rated VGS	I <sub>GSS</sub>	-	-	+100 -100	nA			
Total Gate Charge Gate to Source Charge Gate to Drain Charge	VGS = 10 V 50% rated VDS Rated ID	Qg Qgs Qgd	- - -	80 13 40	120 17 64	nC			
Turn on Delay Time Rise Time Turn off DelayTime Fall Time	VDD=50% rated VDS 50% rated ID RG=6.2Ω	t <sub>d (on)</sub> tr t <sub>d (off)</sub> tf	- - -	20 35 65 40	27 66 100 60	nsec			
<b>Diode Forvard Voltage</b> $(I_S = rated I_D, V_{GS} = 0V, T_J = 25^{\circ}C)$		V <sub>SD</sub>	-	1.47	1.4	V			
Diode Reverse Recovery Time Reverse Recovery Charge	$TJ = 25^{\circ}C$ IF = 10 di/dt = 100A/µsec	t <sub>rr</sub> Q <sub>RR</sub>	-	70	150	nsec			
Input Capacitance Output Capacitance Reverse Transfer Capacitance	VGS =0 Volts VDS =25 Volts f =1 MHz	Ciss Coss Crss	- - -	2600 700 260	2900 1100 275	pF			

For thermal derating curves and other characteristic curves please contact SSDI Marketing Department.

## NOTES:

1/ Maximum current limited by package, die rated at 75A.